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7. Abstract

The U.S. Department of Energy is sponsoring the development of remote, fiber-optic Raman spectroscopy for the rapid chemical characterization of Hanford-Site high-level radioactive tank waste. The deployment targets for this technology are analytical hot cells and, via the Light-Duty Utility Arm and cone penetrometer, the waste tanks themselves. Perceived benefits of fiber-optic Raman spectroscopy are (1) rapid generation of tank-waste safety-related data, (2) reduced personnel exposure to highly radioactive waste, (3) reduced tank-waste sampling and analysis costs, and (4) reduced radioactive analytical waste.

This document presents the results from the investigation of two dispersive, transmission-grating Raman systems and four fiber-optic Raman probe designs with non-radioactive tank waste simulants. One Raman system used a 532-nm, 400 mW, solid-state laser; the other used a 785-nm, 500 mW, solid-state diode laser. We found (1) the transmission-grating systems had better wavelength stability than previously tried Czerny-Turner-based systems and (2) the 785-nm system's specie detection limits in the spectral fingerprint region were at least as good as those for the 532-nm system. Based on these results, and the fact that some tank wastes luminesce with 514.5-nm excitation, we selected the 785-nm system for hot-cell use.

Of the four probes tested, three had a "six-around-one" fiber probe design; the fourth probe was a one-fiber-in-one-fiber-out, diffuse-reflectance design. Comparison of the four probes' signal-to-noise ratios, transmission/collection efficiencies, and probe-silica Raman backgrounds showed that the best probe for use with Hanford-Site tank waste should (1) be filtered as close to the probe tip as possible to reduce the probe-silica Raman background and (2) have multiple collection fibers. The responses of all the probes tested showed a strong dependence on probe-sample distance, and the presence of a probe window appeared to increase the probe's silica Raman background.

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Summary Report of FY 1995 Raman Spectroscopy Technology Development

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LIST OF TRADEMARKS

Trademark	Owner
AST Premmia 4/33	AST Research, Inc.
CSMA	Princeton Instruments, Inc.
GRAMS/386	Galactic Industries Corp.
HoloGrams	Kaiser Optical Systems, Inc.
Holoplex	Kaiser Optical Systems, Inc.
HoloSpec	Kaiser Optical Systems, Inc.
ILX	ILX Lightwave Corp.
SDL	SDL, Inc.
Super-notch Plus	Kaiser Optical Systems, Inc.
WinSpec	Princeton Instruments, Inc.
Wordperfect	Novell, Inc.

LIST OF ACRONYMS AND ABBREVIATIONS

CCD	charge-coupled device
cm	centimeter (10^{-2} meter)
cm^{-1}	reciprocal centimeter (wavenumber)
CT	Czerny-Turner
FY	fiscal year (October 1 - September 30)
HLW	high-level waste
LDUA	Light-Duty Utility Arm
LLNL	Lawrence Livermore National Laboratory
LN	liquid nitrogen
mA	milliampere (10^{-3} ampere)
mm	millimeter (10^{-3} meter)
mW	milliwatt (10^{-3} watt)
N, n	number of measurements
ND	not detected
Nd-YAG	neodymium-yttrium-aluminum-garnet laser
NH	nitrogen-hydrogen
nm	nanometer (10^{-9} meter)
OH	oxygen-hydrogen, hydroxide
RCAL	Raman Chemical Analysis Library
s, sec	seconds
Std. Dev.	standard deviation
TE	thermo-electric
WHC	Westinghouse Hanford Company
WSRC	Westinghouse Savannah River Company
wt%	weight percent
μm	micrometer (10^{-6} meter)

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EXECUTIVE SUMMARY

This report documents the optimization and testing of two Raman spectroscopy systems and four fiber-optic Raman probes in a non-radioactive environment. We are developing Raman spectroscopy systems for the remote characterization of Hanford-Site high-level tank waste. Ultimate deployment of these systems will be both in the hot cell and, *via* the Light-Duty Utility Arm (LDUA) and cone penetrometer, in the waste tanks themselves. The drivers for this development effort are (1) the need to rapidly obtain safety-related information about the organic and ferrocyanide contents of tank waste and (2) the desire to reduce tank waste characterization costs through rapid chemical screening of tank waste. The Department of Energy's Offices of Technology Development and Tank Waste Remediation Systems are jointly sponsoring this development effort.

The Raman systems examined in this report were two Kaiser Optical Systems, Inc., spectrographs – one operating at 532 nm and the other at 785 nm. An Adlas, Inc., doubled neodymium-yttrium-aluminum-garnet (Nd-YAG) laser supplied the 532-nm excitation, while an SDL, Inc., tunable diode laser supplied the 785-nm excitation.

The two Kaiser systems have no moving parts and use transmission gratings instead of the reflective optics and wavelength scanning mechanisms of previously examined Czerny-Turner-based Raman spectrographs. We found that the Kaiser Raman systems exhibited improved wavelength stability, better through-put, and a more compact package than our Czerny-Turner-based Raman systems. These advantages are gained with no loss in resolution, wavelength coverage, or detection limit capability.

Comparisons of the two Kaiser systems led to the choice of the 785-nm system for near-term deployment in the hot cell. The two systems were compared on:

- (1) Signal-to-noise ratios of sodium nitrate and detection limits for various Raman-active components in non-radioactive tank waste simulants. The two systems have similar signal-to-noise ratio characteristics for pure sodium nitrate. The 785-nm system gives somewhat better detection limits for the oxyanion components in the tank waste simulants while the 532-nm system yields better detection limits for ferrocyanide materials.
- (2) Spectral coverage and resolution. The 532-nm system provides spectral coverage up to about 4000 cm^{-1} while the 785-nm system gives covers through about 3100 cm^{-1} ; this implies the 532-nm system can cover the NH- and OH-stretch spectral regions while the 785-nm system cannot. Wavenumber resolution is about equivalent for the two systems.
- (3) Likelihood of the excitation radiation to generate interfering sample luminescence in real tank waste. The likelihood of exciting Raman-interfering sample luminescence increases at shorter wavelengths. We have observed sample luminescence in some real tank waste using

514.5-nm excitation; this interfering luminescence is likely to be greatly reduced with 785-nm excitation. Since sample luminescence, when present, will likely determine the detection limits of components in tank waste, we chose the 785-nm Raman system as the optimal choice for hot-cell deployment.

We measured and compared several optical characteristics of four fiber-optic probes to determine the optimal characteristics of a Raman probe to be used for tank waste measurements. The four probes were: (1) a Westinghouse Savannah River Company (WSRC) LDUA prototype probe with six-around-one fiber arrangement, conical tip, sapphire window, and optical filters; (2) a Lawrence Livermore National Laboratories (LLNL) -supplied probe with six-around-one fiber arrangement, flat-faced probe; no window or filters; (3) an LLNL-supplied probe with six-around-one fiber arrangement, flat-faced, with filters; no window; (4) a Polytec PI, Inc., one-in-one-out probe with filters; no window. The probe characteristics we measured for each probe were: (1) probe silica Raman rejection, (2) "efficiency", (3) overall signal-to-noise ratio, (4) optimal probe-sample separation distance, and (5) probe excitation spot size.

Overall, the WSRC LDUA probe had a good combination of signal-to-noise ratio, efficiency, and probe silica Raman rejection characteristics. However, the Polytec PI probe delivered better signal-to-noise ratio and probe silica Raman rejection values. The responses of all the probes exhibit a strong dependency on the probe-sample lift-off distance. The results of these probe tests indicate that an ideal Raman probe design for Hanford-Site tank waste will have these features:

- (1) optical filters placed as close to the probe tip as possible to minimize the probe's silica response and thus improve signal-to-noise ratio,
- (2) multiple return fibers to yield better collection efficiencies,
- (3) no probe window to degrade the silica rejection afforded by the optical filtering.

The probe should also have a spot size large enough to excite a representative area of the sample (probably > 1 mm) and to minimize photo-induced damage to the sample. Finally, the probe response either should exhibit little dependency on the probe-sample distance, or the probe must be fitted with a mechanism to reproducibly set the probe-sample distance.

We have some additional work to be perform before hot-cell deployment of the 785-nm system in FY 1996. This work includes (1) testing a Kaiser Optical Systems, Inc., 785-nm Raman probe for possible deployment in the hot cell, (2) finalizing and packaging the 785-nm system for hot-cell deployment and (3) selecting the software for instrument control and data reduction.

1.0 INTRODUCTION

1.1 Background

This report summarizes the FY 1995 Raman spectroscopy technology development and testing completed with non-radioactive materials in a non-radioactive environment. The Department of Energy's (DOE) offices of Technology Development (EM-50) and Tank Waste Remediation Systems (EM-30) are jointly sponsoring development of Raman technology to obtain chemical information from Hanford Site high-level radioactive waste (HLW) both in the hot cell and in Hanford Site waste tanks. The principal drivers for this development effort are:

- (1) to obtain safety-related information about the ferrocyanide and organic content of tank waste, and
- (2) to reduce tank waste characterization costs through rapid chemical screening of tank waste.

We performed the Raman spectroscopy work reported in this document using reference materials and non-radioactive, simulated tank wastes in a non-radioactive test facility at the Hanford Site's 305 Building. Non-radioactive testing and development work is part of the development path being followed in the application of Raman spectroscopy to Hanford-Site HLW materials. The EM-50 Office of Technology Development is providing support for the development and optimization of the basic Raman system and system components. The EM-30 Tank Waste Safety and Tank Waste Remediation Systems programs at the Hanford Site are supporting the application of this technology for hot-cell testing and deployment.

Raman spectroscopy uses a laser and a spectrograph to produce vibrational spectra of Raman-active molecules in a sample; the sample may be a gas, liquid, or solid. We can obtain both qualitative and quantitative information from a Raman spectrum. Qualitatively, each molecular specie in the sample generates a different spectral pattern unique to that specie; we can use these patterns to identify the species in the sample. Quantitatively, the intensity of the bands in the spectrum are proportional to the concentration of the species in the sample. Silica optical fibers provide a convenient way to route the laser's emission to a remote sample and return the Raman-scattered radiation to the spectrograph. In simple matrices, remote, fiber-optic Raman spectroscopy can rapidly determine both the identities and amounts of molecular species of interest in Hanford Site HLW (Mann and Vickers 1994).

The need to rapidly and economically identify and quantitate the molecular species in radioactive tank wastes is the principal driver for the development and deployment of remote, fiber-optic Raman spectroscopy. A number of tank waste data quality objectives require characterization data for (1) safe tank farm operations and (2) the development of the technologies required to stabilize and process radioactive waste materials (Brown *et al.* 1995). At present, safe tank farm operations are dominating the need for tank waste characterization data. The existence of

potential organic and ferrocyanide fuels mixed with oxidizers in tank waste raises the possibility of unsafe conditions in the tanks (Postma *et al.* 1994). In the future, we will also need waste characterization data to support technologies for retrieving, processing, and stabilizing radioactive wastes.

To support these characterization data needs, a remote, fiber-optic, Raman spectroscopy probe may provide both qualitative and quantitative data from radioactive tank waste both in the hot cell and in the waste tanks themselves. Deploying remote Raman spectroscopy in a hot cell serves two separate purposes:

- (1) we must verify that remote Raman technology can provide useful information from actual tank waste prior to attempting the expensive deployment of the technology in the tanks themselves and
- (2) we have the added benefit of using the Raman probe as a hot-cell screening tool to allow the rapid collection of characterization data from hot-cell-extruded core segments, the reduction or elimination of sample preparation steps, and the subsequent reduction in the number of traditional chemical analyses.

In the current tank waste characterization process, waste core segments are extracted from a tank and extruded in a hot cell where sub-samples are selected for detailed chemical analyses. The subsequent analytical tests performed on these samples require significant sample preparation and pretreatment. These tests are labor intensive, time consuming, and result in the generation of secondary waste. Use of a hot-cell Raman probe to reduce or eliminate some of these tests will allow savings in cost, time, and personnel exposure. A hot-cell Raman probe may also quickly provide species profiles along the axis of the core sample that are not possible with current methods. These species profiles may help reduce the number of sub-samples required for subsequent laboratory chemical analysis, thus reducing the total analysis cost for a core segment.

We are also pursuing in-tank deployment of remote, fiber-optic Raman probes with the Light Duty Utility Arm (LDUA) and Cone Penetrometer. An in-tank Raman probe could support both qualitative and quantitative analysis and thus reduce the need for waste extraction from a tank and subsequent hot-cell analysis. The use of remote, fiber-optic Raman spectroscopy as a characterization tool for hot-cell and in-tank use offers significant reductions in time, cost, and secondary waste generation; these potential benefits provide the principal motivation for the development of remote, fiber-optic Raman spectroscopy.

1.2 Previous Work

In previous work to support the application of Raman spectroscopy to Hanford-Site tank waste (Lopez *et al.* 1995), we tested several Raman probe designs using a Czerny-Turner-based Raman spectrograph and either 514.5- or 532-nm laser excitation. Those tests examined features of Raman probes that are desirable for use with tank waste. Desirable probe features include (1) optical filters in the probe to reduce the probe's silica response and improved the signal-to-noise ratio in the fingerprint/oxyanion spectral region (but at the expense of the probe's optical throughput) and (2) multiple return fibers to improve the probe's efficiency in delivering light to the spectrograph. Section 3.2 of this document presents results that confirm those previous observations and further our understanding of what features a fiber-optic Raman probe needs for use with tank waste samples.

Lopez *et al.* 1995 also indicated some deficiencies with the Czerny-Turner-based Raman spectrograph and the 514.5- and 532-nm excitation wavelengths. These deficiencies included (1) wavelength drift in the Czerny-Turner spectrograph during operation (probably due to ambient temperature variations), (2) generation of a large ambient heat load by the air-cooled argon-ion laser (514.5-nm source), and (3) the discovery, through diffuse-reflectance spectra, that the tank waste simulants are more likely to absorb the 514.5- and 532-nm wavelengths (and the Raman scattering associated with those wavelengths) than near-infrared wavelengths. Furthermore, some actual tank waste samples exhibit luminescence when excited with 514.5-nm light.

This report presents the results of our investigations to address these deficiencies. We explored the use of two Raman systems based on transmissive optics (instead of the reflective optics of the Czerny-Turner design); one Raman system was optimized for 532-nm operation, the other for 785-nm operation. The 532- and 785-nm lasers used in the current investigation are solid-state lasers with almost none of the excess heat generation of the argon-ion laser. We chose to examine the use of 785-nm excitation to determine how well the longer wavelength excitation would work with tank waste simulants; 785-nm excitation should generate much less luminescence in actual tank samples than green-light excitation. The investigation of near-infrared excitation also follows the recommendation of the *Raman Spectroscopy Peer Review Report* (Winkelman and Eberlein 1994).

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2.0 EXPERIMENTAL

This section outlines the equipment, material, and procedures used to perform equipment tests and measurements. Section 2.1 discusses the four probes examined in this study, Section 2.2 describes the 532-nm and 785-nm Raman systems, Section 2.3 outlines materials and sample preparation, and Section 2.4 describes the non-laser light sources used in this study.

2.1 Fiber-Optic Raman Probes

We examined four probes in these studies; see Figures 2.1 - 2.5 for diagrams of each probe:

- (1) Westinghouse Savannah River Company (WSRC) Light-Duty Utility Arm (LDUA) probe: six-around-one, 400- μ m diameter, stepped-index silica fibers, conical tip, with sapphire window and optical filters (Figures 2.1, 2.2),
- (2) Lawrence Livermore National Laboratories (LLNL) -supplied probe: six-around-one, 400- μ m diameter, stepped-index silica fibers, flat-faced; no window or filters (Figure 2.3),
- (3) LLNL-supplied probe: six-around-one, 200- μ m diameter, stepped-index silica fibers, flat-faced with filters; no window (Figure 2.4),
- (4) Polytec PI, Inc., one-in-one-out probe with filters; no window (Figure 2.5).

Probe (1) is a prototype probe for the LDUA. This probe differs from others previously examined in that it has in-line filters much closer to the probe tip (see Figure 2.1) and has a conical tip that provides more complete overlap between the excitation region of the central fiber and the viewing regions of the surrounding fibers (see Figure 2.2). Probe (3) is similar in design to probe (2) except that probe (3) has 200- μ m fibers and in-line filters. The desire to test a 200- μ m fiber probe was to determine if matching fiber diameter more closely to the spectrograph's slit width would improve the Raman system's overall throughput. Lopez *et al.* 1995, contains more complete descriptions of probes (2) and (4).

CVI Laser Corp. (Albuquerque, NM) provided the optical filters used in the filtered probes. The filters are nominally 3-mm in diameter and 0.5-mm thick to allow insertion in standard SMA-905 connectors. The laser band-pass filters are dielectric filters with a peak transmission of *ca.* 50% at 532 ± 0.6 nm or 785 ± 0.6 nm and a half-height peak width of *ca.* 6 nm. The long-pass filters have a transmittance of about 12% at the laser wavelength and a maximum transmittance of about 70% at wavelengths about 80 nm longer than the excitation wavelength.

Figure 2.1. Probe (1): WSRC Prototype Raman Probe-Head Design for *In Situ* Tank Deployment with the Light-Duty Utility Arm.

Figure 2.2. Probe (1): Optical Design of the WSRC Prototype Raman Probe Head.

Figure 2.3. Probe (2): LLNL Flat-Face, 6-Around-1, Fiber-Optic Probe.

Figure 2.4. Probe (3): LLNL Flat-Face, 6-Around-1 Fiber-Optic Probe with In-Line Optical Filters.

Figure 2.5. Probe (4): Diffuse-Reflectance Probe with In-Line Optical Filters.

2.2 Raman Spectroscopy Systems

532-nm System: The 532-nm system used an Adlas, Inc., (Stow, MA) model DPY 425II doubled Nd-YAG laser with a maximum output of *ca.* 400 mW. The spectrograph was a Kaiser Optical Systems, Inc., (Ann Arbor, MI) *HoloSpec f/1.8i* equipped with a "slant-fringe" grating. The spectrograph uses a built-in collimated optical pre-filter stage containing a Kaiser HSPF-532AR-2.0 holographic *Super-notch Plus*TM filter to reject the Rayleigh line. Figure 2.6 shows the optical layout of both the 532-nm and 785-nm Kaiser spectrographs. Two different charge-coupled device (CCD) imaging detectors were used with this system: a Princeton Instruments, Inc., (Trenton, NJ) LN/CCD-1024TKB operated at -120°C or a TEA/CCD-1152EM/1 operated at -40°C. The detectors were controlled by means of a Princeton Instruments ST130 detector controller.

Figure 2.6. Optical Layout of Kaiser Optical Systems, Inc., *HoloSpec f/1.8* Transmission Grating Spectrograph.

785-nm System: The 785-nm system used an SDL, Inc., (San Jose, CA) model SDL-8630 tunable diode laser with a maximum output of *ca.* 500 mW at 785 nm. The laser's power supply and temperature controller was an ILX Lightwave Corp. (Bozeman, MT) model LDC-3900 *Modular Laser Diode Controller* equipped with a model 39032 thermoelectric temperature controller and model 39400M current source. The output of the laser was first routed through a 200- μ m diameter, 1-m long fiber-optic pigtail; the free end of the pigtail consisted of an SMA-905 connector containing a 785-nm band-pass dielectric filter to reduce the super-radiant output from the laser. The excitation fiber of the Raman probes tested with the 785-nm system were then connected to the SMA-905/filter connector. The spectrograph was a Kaiser Optical Systems, Inc., *HoloSpec f/1.8i NIR* equipped with a "slant-fringe" grating and a Princeton Instruments, Inc., LN/CCD-1024TKB CCD detector operated at -120°C . The spectrograph uses a built-in collimated optical pre-filter stage containing a Kaiser HSPF-785AR-2.0 holographic *Super-notch PlusTM* filter to reject the Rayleigh line. The detector was controlled by means of a Princeton Instruments ST130 detector controller.

CCD Detectors: The LN/CCD-1024TKB detector contains an anti-reflection-coated, back-illuminated CCD chip with a 1024x1024 pixel format; the chip active area measures 24.6x24.6 mm with a pixel size of 24x24 μ m. The TEA/CCD-1152EM/1 detector contains a front-illuminated CCD chip with a 1152x298 pixel format; the chip active area measures 26x6.7 mm with a pixel size of 22.5x22.5 μ m. Both detectors are equipped with 16-bit analog-to-digital converters and were operated at 50 KHz. Detector binning parameters were set to include only those rows of the CCD that contained the fiber images.

Data Collection: The data-collection computer used with either system was an AST Premmia 4/33TM running either Princeton Instrument's *CSMA 2.4a* software or Florida State University's *RCAL* software (Mann and Vickers 1994). Data collection and reduction procedures are described in Lopez *et al.* 1995.

2.3 Materials and Sample Preparation

Reagent-grade potassium chloride (used as the target to obtain the probe silica response) and sodium nitrate were dried, milled and pressed into pellets approximately 1 cm in diameter and 1-cm thick. Other reagents were used as received. Appendix A describes the tank waste simulants. To avoid possible laser-induced sample damage, we mounted the sodium nickel ferrocyanide and tank waste simulant samples on a rotating stage with a rotation rate of *ca.* two revolutions per minute. After mounting the samples on the rotating stage, we used the edge of a rubber policeman to smooth the sample to a uniform thickness, then mounted the fiber-optic probe to allow a one-millimeter spacing between the end of the probe and the surface of the rotating sample. We obtained Raman spectra of liquid samples by immersing the probe directly into the liquid.

2.4 Light Sources

An Oriel Corp. (Stratford, CT) 6032 neon pen lamp provided neon reference lines for wavelength calibration; emissions lines from the laboratory's high-pressure mercury arc lights were also used in conjunction with the neon lamp. A Titan Tool Supply Company, Inc., (Buffalo, NY) model FO-150 tungsten-halogen lamp was the white-light source. We used a 400 watt, high-pressure sodium lamp to simulate the lighting expected in the hot cell. Appendix B contains spectra of the neon wavelength calibration lines at 532 nm and 785 nm and the sodium lamp lines obtained with the Kaiser 785-nm system. We obtained reference values for the wavelengths of the mercury, neon, and sodium lines from Phelps 1982 and Zaidel' *et al.* 1970.

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3.0 RESULTS AND DISCUSSION

3.1 532-nm vs. 785-nm Excitation

3.1.1 Wavenumber Range and Spectral Resolution

Table 3.1 compares the spectral ranges and resolutions covered by the 532-nm and 785-nm systems; the 532-nm has the advantage of covering larger Stokes shifts that include NH and OH stretch regions. The primary limitation of the 785-nm system's spectral range is the poor quantum efficiency of silicon CCD detectors beyond 1050 nm. Appendix C contains comparison Raman spectra of several pure materials and tank waste simulants obtained with both the 532-nm and 785-nm Raman systems.

Table 3.1. Comparison of Wavelength and Wavenumber Coverage and Resolution for the 532-nm and 785-nm Systems.

HSG-532-LF (2450)	533 - 608 (1.2)	11 - 2354 (42 - 32)	"fingerprint", oxyanions, ferrocyanides
HSG-532-HF (2210)	591 - 675 (1.3)	1872 - 3975 (37 - 29)	ferrocyanides, C-H, N-H, O-H stretch
HSG-785-LF (1620)	798 - 913 (2.0)	208 - 1786 (31 - 24)	"fingerprint", oxyanions
HSG-785-HF (1430)	906 - 1037 (2.9)	1701 - 3096 (35 - 27)	ferrocyanide, C-H stretch

^aLF = "low frequency" grating; HF = "high frequency" grating; g/mm = grating line density in grooves per millimeter.

^bResolution is defined as twice the peak width at half height for neon atomic lines in the respective window; slit width = 167 μ m.

^cWhen resolution is converted from the wavelength to the Stokes shift domain, spectral resolution improves with increasing wavenumber.

3.1.2 Signal-to-Noise Ratios and Detection Limits

Table 3.2 shows that the sodium nitrate target signal-to-noise ratio of the 785-nm system (equipped with the LN/CCD-1024TKB detector) is not statistically different from that of the 532-nm system (equipped with the TEA/CCD-1152EM/1 detector). Differences in the detectors influence these results somewhat since the LN detector generates a better signal-to-noise ratio than the TE detector at 532 nm (see Section 3.3.3 and Table 3.6). The results in Table 3.2 do indicate that factors besides "v" appear to also influence the signal-to-noise ratio characteristics of the system. These factors may include the detector quantum efficiency, the read-out and shot noise characteristics of the silicon CCD detector, the transmission characteristics of the silica fibers, and the optical characteristics of the sample.

Table 3.2. Comparison of Signal-to-Noise Ratios for the 532-nm and 785-nm Systems.

532	3731 ^b	104	3
785	3685 ^c	573	8

^aSignal/noise = baseline-corrected peak height of the 1067.5 cm⁻¹ sodium nitrate band divided by the standard deviation of the noise on the baseline from ca. 1112 to 1341 cm⁻¹.

^b532-nm conditions = WSRC LDUA probe, 22 mW power at sample, 167-μm slits, TEA/CCD-1152EM/1 detector at -40°C, 60 second total integration time.

^c785-nm conditions = WSRC LDUA probe, 39 mW power at sample, 167-μm slits, LN/CCD-1024TKB detector at -120°C, 60 second total integration time.

Table 3.3 shows calculated detection limits of various species measured in the simulants. In general, detection limits for nitrate, nitrite, and bismuth phosphate are somewhat better with 785-nm excitation (with the LN CCD detector) than with the 532-nm excitation (with the TE CCD detector). The improved detection limits with the 785-nm over the 532-nm system in the oxyanion region probably reflect, to a certain extent, the better noise characteristics of the LN detector, but also may be a function of improved fiber transmission and decreased optical absorption of the simulants in the near-infrared. In contrast, detection limits for sodium nickel ferrocyanide are about the same for the two systems except for the T-Plant bottom simulant: the presence of 0.8 wt% sodium nickel ferrocyanide in the T-Plant bottom simulant was detected only with the 532-nm system and detected not at all with the 785-nm system. The nearly equal or slightly poorer detection limits of the 785-nm system in the ferrocyanide region are probably due to the rapid drop in detector quantum efficiency in near-infrared region and the etalon effect observed in the LN detector (see Section 3.3.3).

Table 3.3. Comparison of Specie Detection Limits for 532-nm and 785-nm Systems.

sodium nitrate	BY-104	2.2	0.25
	In-Farm 2	0.15	0.21
	SY-101	0.71	0.15
	T-111 top fraction	0.85	0.40
sodium nitrite	In-Farm 2	0.74	1.1
	SY-101	3.6	0.60
bismuth phosphate	T-111 bottom frac.	1.3	0.80
sodium nickel ferrocyanide	In-Farm 2	0.38	0.41
	T-111 top fraction	0.86	0.90
	T-111 bottom frac.	0.43	ND ^d

^aDetection Limit = $3 \times (\text{weight\% specie in sample}) \times (\text{spectral baseline standard deviation} \div \text{baseline-corrected peak height})$.

^b532-nm conditions = WSRC LDUA probe, 22 mW power at sample, 167- μ m slits, TEA/CCD-1152EM/1 detector at -40°C, 300 second total integration time.

^c785-nm conditions = WSRC LDUA probe, 27 mW power at sample, 167- μ m slits, LN/CCD-1024TKB detector at -120°C, 300 second total integration time.

^dND = not detected.

Finally, since some real tank waste samples exhibit fluorescence when illuminated with 514.5-nm laser radiation, we chose the 785-nm system for the examination of real tank waste in the hot cell. In the presence of sample fluorescence, the 785-nm system will likely demonstrate better detection limits than the 532-nm system.

3.2 Comparison of Fiber-Optic Raman Probes

3.2.1 Spot Size and Optimal Probe-Sample Distance

The spot size for the WSRC LDUA probe is approximately 0.8 mm; this is similar to the spot sizes of the other six-around-one probes tested. The Polytec PI probe has a spot size of 4 mm. All spot sizes were measured at the plane of maximum overlap between the excitation and collection fibers.

Figure 3.1 shows the probe response as a function of the distance between the probe and target for three of the fiber-optic Raman probes. The data for these curves were generated by transmitting white light through the excitation fiber of each probe (in the case of the filtered

Figure 3.1. Probe Response as a Function of Probe/Target Separation Distance for Three Fiber-Optic Raman Probes.

probes, the white light is filtered prior to reaching the target) and aiming the probe at a flat-black surface. Using a vertical axis translation stage equipped with a precision micrometer, spectra were taken with the probe first at zero-mm separation from the target, then at incremental probe-target separations to a maximum distance of four or five millimeters. A second set of spectra were then taken in reverse order (decremental probe-target separation) until the probe again contacted the target. Each resulting spectrum exhibited a broad spectral band; the area under this band was integrated and plotted *versus* separation distance to yield Figure 3.1. We did not measure the probe response *versus* lift-off distance performance for the Polytec PI probe since that probe is designed to have maximum excitation-collection overlap in the plane of the probe's sample-contact rim.

Figure 3.1 shows that all three probes exhibit a maximum response at a probe-target separation of about one mm. Furthermore, optimal probe response is quite critically dependent upon probe-target separation: an error as small as 0.25 mm in positioning the probe from the target will have appreciable effect on the probe's response. The WSRC LDUA probe shows different behavior from the two LLNL probes at zero-mm separation from the target. Because of its window, the WSRC LDUA probe registers some response at zero-mm separation, whereas the two windowless LLNL probes yielded no response at zero-mm separation.

3.2.2 Probe Signal-to-Noise Ratios, Efficiencies, and Nitrate/Silica Peak Ratios

Table 3.4 compares the four fiber-optic Raman probes tested in this study. Using a sodium nitrate pellet target with a one-mm probe-target separation, three metrics were measured for probe comparison: signal-to-noise ratio, "efficiency", and nitrate/silica peak ratio. Calculations for these characteristics are outlined in the notes for Table 3.4. In general, the LLNL six-around-one, flat-face, unfiltered probe provided the best nitrate signal-to-noise ratio and best efficiency; however, it also produced the poorest nitrate/silica peak ratio. The lack of filters in the LLNL unfiltered probe is the explanation for these results: the unfiltered optical path allows significantly better optical throughput through the probe, but provides no filtering for the silica Raman background generated in the probe.

Conversely, because of optical filtering, the WSRC LDUA probe produced a poorer nitrate signal-to-noise ratio, but a significantly better nitrate/silica Raman ratio, than those of the LLNL unfiltered probe. The WSRC probe's overall performance is somewhat better than the LLNL 1:6 flat-face *filtered* probe. There are three design differences between the WSRC LDUA probe and the LLNL filtered probe that may contribute to these performance differences: (1) the WSRC probe has a more efficient conical-tip design than the LLNL flat-face probe, (2) the WSRC probe has 400- μ m fiber construction; the LLNL filtered probe has 200- μ m fibers, and (3) the WSRC probe has only *ca.* five cm of fiber between its tip and filters while the LLNL filtered probe has about 30 cm between its tip and filters; the longer unfiltered path in the LLNL probe will

generate a greater silica-fiber Raman background. Because of the design differences between the WSRC probe and the LLNL filtered probe, we cannot say with certainty that using 200- μ m fibers to better match to the spectrometer's slit width yields any advantage.

Table 3.4. Comparison of Probe Characteristics for Fiber-Optic Raman Probes.

WSRC/LDUA 1:6, filtered	1387 ± 167 (6)	2.30×10^6 $\pm 0.10 \times 10^6$ (6)	1.96 ± 0.11 (8)
LLNL 1:6, non-filtered	6752 (1)	2.74×10^6 (1)	0.63 (1)
Polytec PI 1:1, filtered	4601 (1)	0.386×10^6 (1)	20.9 (1)
WSRC/LDUA 1:6, filtered	3665 ± 573 (8)	0.354×10^6 $\pm 0.036 \times 10^6$ (8)	3.07 ± 0.17 (8)
LLNL 1:6, non-filtered	6624 ± 583 (7)	2.24×10^6 $\pm 0.35 \times 10^6$ (7)	0.28 ± 0.01 (7)
LLNL 1:6, filtered	2532 ± 222 (10)	0.271×10^6 $\pm 0.014 \times 10^6$ (10)	1.84 ± 0.20 (10)

^aSignal/noise = baseline-corrected peak height of the 1067.5 cm^{-1} sodium nitrate band divided by the standard deviation of the noise on the baseline from ca. 1112 to 1341 cm^{-1} ; sd = standard deviation of the mean value; n = number of measurements; 60-s integration time used for all measurements.

^bEfficiency = baseline-corrected peak height of the 1067.5 cm^{-1} sodium nitrate band divided by (laser power at sample in watts times the exposure time).

^cSodium nitrate/silica ratio = background-corrected peak height of the sodium nitrate 723 cm^{-1} band divided by the background-corrected peak height of the silica 799 cm^{-1} band.

The Polytec PI probe generated a reasonable nitrate signal-to-noise ratio and had the best nitrate/silica peak ratio but also exhibited one of the poorest efficiencies due to its single collection fiber. The filtered Polytec probe's excellent nitrate/silica peak ratio is probably due to (1) its lack of a window and (2) the positioning of the Polytec's optical filters at the very tip of the excitation and collection fibers. In contrast, the WSRC probe has a window and has about five cm of silica fiber between the optical filters and the probe tip; these features may contribute

to the poorer nitrate/silica value when compared to the Polytec probe. (The WSRC probe was not designed to allow the probe window to be removed; hence we could not directly test the effect of the WSRC LDUA probe window on the nitrate/silica peak ratio.)

The efficiency for the LLNL unfiltered probe appears to be consistent between the two excitation wavelengths examined, while the efficiencies of the WSRC probe at the two wavelengths differ by an order of magnitude. (In fact, we would predict that efficiency *should* show a definite wavelength dependence.) The reason for the discrepancy between the efficiency behavior of the two probes at the two different wavelengths is not immediately apparent.

The conclusions from the comparison of these probes are:

- (1) Probe-sample distance is critical for optimal probe performance.
- (2) Optical filtering greatly improves the sample Raman signal compared to the probe-generated silica signal; filtering should be performed as close to the probe tip as possible for maximum efficacy.
- (3) Optical filtering also reduces the throughput of the probe; filtering should be used only as required to remove the silica background from the Raman signal (below *ca.* 1800 cm^{-1}).
- (4) Multiple return fibers yield better collection efficiencies.
- (5) The presence of a probe window may degrade the silica rejection afforded by optical filtering.

While we performed no studies specifically to determine an optimal excitation-collection spot size for a Raman probe, we can anticipate that larger spot sizes will provide more representative information from heterogeneous tank waste samples. Conversely, larger spot sizes will likely be accompanied by poorer collection efficiencies of the Raman scattered light from the sample.

3.3 Instrument Operational Performance

3.3.1 785-nm Diode Laser

During the performance of these studies, we used the SDL-8630 diode laser for about 12 hours; we used no optical isolation between the laser and the fiber-optic interface. The laser generated its most stable power output when used in "constant power" operation as opposed to "constant current" mode. We did not directly monitor the frequency stability of the laser during operation; however, we noticed no overt "mode-hopping" during collection of Raman spectra during two-to-four spectral data collection campaigns. The "super-radiant" (non-laser) background output of

the laser was significant enough that we found it necessary to add a laser-band-pass filter to the output of the laser to reduce laser-generated background in the Raman spectra.

After approximately 12 hours of laboratory operation, the diode laser failed. The failure was characterized by the laser power supply "pegging" at the current limit (1750 mA) and low power output (2 mW). Consultation with SDL, Inc., indicated that the most likely cause of failure was catastrophic failure of the laser diode itself; SDL attributed the failure to lack of optical isolation between the laser and the fiber-optic interface. Consequently, we have designed and will install a Faraday-rotator-based optical-isolator interface between the repaired laser and its fiber-optic coupling. The interface will also incorporate a holder for a narrow band-pass laser filter, a solenoid-operated shutter, and an XY-tilt fiber-optic positioner with an SMA-905 coupling.

3.3.2 Kaiser Spectrographs

The Kaiser *HoloSpec f/1.8i* spectrographs exhibited three advantages over previously used Czerny-Turner (CT) spectrographs. (1) The Kaiser systems exhibited excellent wavelength stability. This feature was most evident during spectral subtractions of probe-silica background from non-silica-corrected Raman spectra; probe-silica backgrounds subtracted cleanly with no residual features indicative of wavelength offsets between the probe-silica reference spectrum and sample Raman spectra. Such offsets were common with the CT Raman systems. (2) The *HoloSpec* spectrograph has a fast f/number that more closely matches the f/number of our silica fibers; the low f/number ensures that the solid-angle output of the fiber-optic is well-matched to the spectrograph. Properly matched optics will contribute to (a) minimal signal loss in the optical system and (b) minimal stray light introduced into the detector. (3) The Kaiser systems have a smaller footprint than any of the previously used CT systems; this makes a much more compact total Raman package.

We also noted two problems with the Kaiser spectrographs. (1) The wavelength calibration of the Kaiser system is very non-linear. With the previous CT systems, we obtained excellent least-squares fits of wavelength to pixel number using, at most, quadratic fits. The Kaiser spectrographs required a cubic fit to obtain, at best, an adequate least-squares fit. Discussions with Kaiser engineers revealed that the holographic gratings used in these systems imposes a sinusoidal variation in wavelength on the detector. Kaiser personnel claim that their *HoloGrams*TM software can perform an adequate calibration with their hardware; we have not yet tested this claim in our laboratory. In any event, proper wavelength calibration of the Kaiser system may require more sophisticated calibration methods (e.g. higher-order least-squares fits or piece-wise lower-order fits over short detector regions).

(2) The Kaiser systems have a built-in detector "wobble plate" to allow adjustment of the detector to the focal plane of the spectrograph. The vendor's literature outlines a procedure to adjust the wobble plate and spectrograph focus for best spectral resolution across the face of the CCD chip. Adjustments to the wobble plate appeared to produce little effect on spectral resolution; we therefore found it difficult to determine if the detector was optimally oriented at the focal plane of the spectrograph. Better procedures will need to be developed to ensure that the detector is optimally positioned at the spectrograph's focal plane to provide maximum spectral resolution.

We also measured the signal-to-noise ratio performance of the 532-nm system at two different slit widths: 167 and 250 μm ; Table 3.5 shows the results. Surprisingly, the 167- μm slit yielded a significantly higher signal-to-noise ratio than the 250- μm slit. This may be due to reduced stray light or reduced shot noise at the detector when using the narrower slit. Correct selection of slit width requires balancing spectrograph throughput and the sampling rate across the narrowest feature expected in the spectrum (Douglas 1994). While the original recommendation was to maintain a sampling rate of ≥ 10 points above a peak's half-height, it appears that sampling rates of from five to six sample points above a peak's half-height is adequate for proper spectral subtraction. Since the 167- μm slit met this sampling rate criterion, we used the 167- μm slit for most of the work presented in this document.

Table 3.5. Comparison of Signal-to-Noise Ratios for 167- μm and 250- μm Slit Widths.^a

Slit Width (μm)	Signal-to-Noise Ratio	Sampling Rate (points)	Standard Deviation
167	3731	104	3
250	1387	187	6

^aAll data collected using the WSRC-LDUA 1:6 probe with filters, 532-nm excitation, the TEA/CCD-1152EM/1 detector, and 60-s total integration times.

^bSignal/noise = baseline-corrected peak height of the 1067.5 cm^{-1} sodium nitrate band divided by the standard deviation of the noise on the baseline from ca. 1112 to 1341 cm^{-1} .

3.3.3 CCD Detectors

We tested the two CCD detectors noted in Section 2.2 – a Princeton Instruments, Inc. (Trenton, NJ), LN/CCD-1024TKB operated at -120°C and a TEA/CCD-1152EM/1 operated at -40°C . We compared the signal-to-noise ratio characteristics of the two detectors measured using the 1067.5 cm^{-1} band of sodium nitrate with 532-nm excitation; Table 3.6 lists the results and measurement conditions. The LN detector has a significantly greater signal-to-noise ratio under

the measurement conditions employed. We did not perform the same comparison at 785 nm. However, since the LN detector exhibits some etalon behavior at 785 nm (*vide infra*), we will make an additional comparison at 785 nm to determine if the superior sensitivity of the LN detector at long wavelengths outweighs the detector-produced etalon noise.

Table 3.6. Comparison of Signal-to-Noise Ratios for the LN/CCD-1024TKB and TEA/CCD-1152EM/1 CCD Detectors.^a

LN/CCD-1024TKB	2621	461	3
TEA/CCD-1152EM/1	1387	187	6

^aAll data collected using the WSRC LDUA 1:6 probe with filters, 532-nm excitation, 250- μ m slits, and 60-s total integration times.

^bSignal/noise = baseline-corrected peak height of the 1067.5 cm^{-1} sodium nitrate band divided by the standard deviation of the noise on the baseline from ca. 1112 to 1341 cm^{-1} .

Figure 3.2 shows the white-light spectra for the LN detector obtained with both the 532-nm and 785-nm systems using the various gratings characterized in Table 3.1. The LN detector exhibits a noticeable etalon effect at 785 nm that is not seen at 532 nm. The etalon effect becomes more pronounced with increasing wavelength. Since the etalon pattern is dependent upon the "mix" of wavelengths in the spectrum, it will not completely ratio out with white-light spectral correction. Therefore, we can anticipate that the etalon effect, coupled with the detector's decreasing quantum efficiency with increasing wavelength, will cause species with Stokes shifts greater than about 2100 cm^{-1} to suffer from poorer detection limits with 785-nm excitation than with 532-nm excitation. The TE detector exhibits no noticeable etalon effect at 532 nm; we have not yet tested this detector at 785 nm to see to what extent it exhibits etalon effects at longer wavelengths.

While the LN detector has better quantum efficiency than the TE detector at 532 nm, the TE detector does have three advantages over the LN system. (1) The TE detector is thermoelectrically cooled and does not require liquid nitrogen. (2) The TE detector has a faster data acquisition rate than the LN system. The LN detector has a latency of about three seconds for every frame of data collected while the TE detector's latency is less than one second. This means that the TE detector can collect spectra faster than the LN system when co-adding large numbers of short-exposure-time spectra. (3) The TE detector is a smaller package and allows a more compact instrument.

Figure 3.2. White-Light Spectra for 532-nm and 785-nm Gratings with LN/CCD-1024TKB CCD Detector.

Based on the better signal-to-noise performance of the LN detector using 532-nm excitation and the LN's superior quantum efficiency at long wavelengths, we decided to use the LN detector for the 785-nm system. However, should the difference in signal-to-noise performance for the two detectors be less than about a factor of two at 785 nm, then the TE may be the detector of choice based on its other advantages over the LN detector.

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4.0 CONCLUSIONS AND FUTURE WORK

4.1 Conclusions

4.1.1 Selection of 785-nm Raman System

We have determined that the optimal Raman system for the examination of Hanford-Site high-level waste is a 785-nm system based on an SDL, Inc., laser and a Kaiser Optical Systems, Inc., spectrograph. This decision is based upon

- (1) the near-equivalent signal-to-noise ratio and detection limit performance of the 532-nm and 785-nm Raman systems using tank waste simulants,
- (2) the likelihood that 532-nm excitation-induced luminescence in some Hanford-Site tank waste samples will "swamp" the Raman signals from those samples; 785-nm excitation should yield better Raman signal-to-noise ratios in the presence of sample luminescence.
- (3) the superior wavelength stability of the transmission-grating spectrograph over previously used Czerny-Turner scanning spectrographs.

The major trade-offs in selecting the 785-nm system are

- (1) the NH- or OH-stretch regions are accessible with the 532-nm system but not the with 785-nm system, and
- (2) the signal-to-noise ratio in the CH-stretch region will be somewhat poorer for the 785-nm system than the 532-nm system.

4.1.2 Probe Selection

Based on the work presented in this document, the probe should have the following design features:

- (1) optical filters placed as close to the probe tip as possible to minimize the probe's silica response and thus improve signal-to-noise ratio,
- (2) multiple return fibers to yield better collection efficiencies,
- (3) no probe window to degrade the silica rejection afforded by the optical filtering, and
- (4) some mechanism to accurately and reproducibly position the probe with respect to the sample (for hot-cell operation).

We would also like a large excitation spot size (probably > 1 mm) to (a) excite a representative area of the sample and (b) reduce possible laser-induced photo-damage to the sample.

Some trade-offs may compromise the final probe design. For example, if it is not feasible to build a mechanism to accurately position the probe with respect to the sample in the hot cell, then a sample-contacting probe with a window may be a necessity. A windowed contact probe, however, generates additional problems besides increased window-generated probe backgrounds; a window that contacts the sample may chemically cross-contaminate the sample as the probe is moved from site to site on the sample. Chemical cross-contamination may affect the accuracy of the Raman data collected from the sample and will require either (1) washing the probe between samples or (2) providing the probe with a protective cover that is disposed between sample points. Either washing or disposable probe covers will generate an undesirable waste stream. Cone penetrometer deployment of a Raman probe will obviously require the use of an optical window; therefore, the issues of probe background response and possible sample carry-over as the penetrometer is pushed into the waste will need to be addressed.

4.2 Future Work

A number of issues remain to be addressed before final deployment of a 785-nm Raman system. These issues fall generally into four categories:

- (1) final system optimization
- (2) final selection of a probe design,
- (3) packaging of the system for deployment, and
- (4) selection of software to (a) operate the system and (b) perform data reduction.

4.2.1 Final System Optimization

This task will entail testing two variations in the 785-nm system: (1) the use of the TEA/CCD-1152EM/1 CCD detector and (2) the addition of a Kaiser *Holoplex*TM grating to the spectrograph. Tests with the TEA detector will allow us to determine how severely the etalon effect evident with the LN/CCD-1024TKB detector affects detection limits. The addition of the *Holoplex* grating will allow us to gather the complete Raman spectrum from *ca.* -50 to 3000 cm^{-1} with no change in grating and no loss of resolution.

4.2.2 Final Selection of Probe Design

We have received, but not yet tested, a 785-nm probe from Kaiser Optical Systems, Inc., for use with our 785-nm system. This probe has most of the characteristics noted in Section 4.1.2. The probe head is equipped with holographic filters to provide maximum probe-silica signal rejection. The probe can also be equipped with a seven-fiber return bundle (six-around-one design) to maximize Raman signal collection from the sample. While the probe is normally operated with an optic to focus the excitation spot on the sample, the probe can be operated without the optic to provide a pseudo-collimated excitation and collection region of about five-mm diameter.

4.2.3 Packaging Raman System for Hot-Cell Deployment

We must address several issues prior to deployment of the 785-nm Raman system into the hot-cell environment:

- (1) Probe related issues:
 - (a) design and build a mechanism to accurately and reproducibly position the probe with respect to the sample,
 - (b) design and build an ambient light shield to protect the probe from hot-cell lights,
 - (c) design and build a parking station to hold and protect the probe when not in use;
- (2) Attach an optically isolated fiber-optic interface to the 785-nm laser;
- (3) Design and build a radiation shield for the CCD detector;
- (4) Design and build white-light and neon line reference light sources for hot cell use;
- (5) Select chemical references for hot-cell use; design and build holders for references;
- (6) Install the Raman system into a final package (e.g. a roll-around cart).

We have already generated conceptual designs to deal with most of these issues. Much of the preliminary work in FY 1996 will be to finish the detailed design and implementation of the conceptual designs.

4.2.4 Selection of Operating and Data-Reduction Software

We have three possible choices for data collection software: (1) Florida State University's *RCAL* software (Mann and Vickers 1994), (2) Princeton Instruments, Inc., *WinSpec*TM software, and (3) Kaiser Optical Systems, Inc., *HoloGrams*TM software. Of these three, only selections (2) and (3) are capable of obtaining spectra from a Kaiser spectrograph equipped with a *Holoplex* grating.

The *HoloGrams* software has built-in wavelength calibration routines for use with the Kaiser spectrograph, so that software will probably be our first choice for Raman data collection.

To produce interpretable Raman spectra, several data reduction steps are required (Douglas 1994, Lopez *et al.* 1995). The *HoloGrams* software is capable of performing most of these steps (*e.g.* dark-charge correction, white-light ratioing, probe background subtraction, and wavelength calibration). However, more advanced data manipulation techniques, *e.g.* removal of non-Raman background features (luminescence), spectral smoothing, or factor analysis, are not immediately available in *HoloGrams*. These advanced functions will require either (1) writing routines in *GRAMS/386™* or (2) exporting data to *RCAL* routines that can perform these functions.

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APPENDIX A: TANK WASTE SIMULANT CHEMICAL COMPOSITIONS

We used five tank waste simulants in the work reported in this document. These simulants represent a portion of the range of optical, physical, and chemical properties suspected to be present in real tank wastes. How accurately these materials actually simulate the Raman response from real tank waste is yet to be fully determined.

- (1) BY-104 saltcake simulant (Table A.1): The BY-104 simulant represents the salt-cake material found on the surface of the waste in tank BY-104. The simulant ranges in color from light tan to brown with increasing water content. The material ranges from a coarse, loosely aggregated sand when dry to a gritty paste when wet.
- (2) In-Farm 2 "mixed" simulant (Table A.2): This simulant was generated using the In-Farm ferrocyanide flow sheet (Jeppson and Wong 1993). The simulant is a translucent, pale blue, gelatinous material.
- (3) SY-101 simulant (Table A.3): This material simulates the SY-101 tank waste "Window E" sample composition. Tank SY-101 is classified as a complexant concentrate tank. This simulant contains a representative amount of organic carbon in the form of tetrasodium EDTA. The material is a dark olive-drab color with a thin, paste-like consistency containing bits of crystalline material.
- (4) T-Plant simulant, top fraction (Table A.4): The T-Plant ferrocyanide flow sheet was used to generate this simulant; the simulant is the top *ca.* 90 weight percent of the centrifuged product (Jeppson and Simpson 1994). Actual tank waste produced from the T-Plant flow sheet were originally deposited in the TY tank farm. The simulant is a sludge with a tan color and the consistency of peanut butter.
- (5) T-Plant simulant, bottom fraction (Table A.5): This material is the bottom *ca.* 10 weight percent of the centrifuged product generated in conjunction with the T-Plant top fraction (Jeppson and Simpson 1994). This simulant is a sludge with a dark tan color and the consistency of peanut butter.

Table A.1. BY-104 Salt-Cake Simulant Composition.

sodium nitrate	NaNO_3	81.8
sodium aluminate	NaAlO_2	7.5
sodium hydroxide	NaOH	1.7
sodium silicate	Na_2SiO_3	1.5
ferric nitrate	$\text{Fe}(\text{NO}_3)_3$	1
sodium phosphate	Na_3PO_4	0.7
calcium nitrate	$\text{Ca}(\text{NO}_3)_2$	0.4
magnesium nitrate	$\text{Mg}(\text{NO}_3)_2$	0.2
manganese nitrate	$\text{Mn}(\text{NO}_3)_2$	0.2
water	H_2O	ca. 5

Table A.2. In-Farm 2 "Mixed" Simulant Composition.

sodium nitrate	NaNO_3	18.5
sodium phosphate	Na_3PO_4	6.1
sodium nitrite	NaNO_2	5.3
disodium nickel ferrocyanide	$\text{Na}_2\text{NiFe}(\text{CN})_6$	10.8
sodium sulfate	Na_2SO_4	1.8
calcium nitrate	$\text{Ca}(\text{NO}_3)_2$	0.53
sodium hydroxide	NaOH	0.003
bound water	H_2O	2.7
free water	H_2O	54.4

Table A.3. SY-101 Simulant Composition.

sodium nitrite	NaNO_2	16.2
sodium aluminate	$\text{NaAlO}_2 \cdot 2\text{H}_2\text{O}$	14.5
sodium nitrate	NaNO_3	13.4
sodium hydroxide	NaOH	7.1
sodium carbonate	Na_2CO_3	6.7
tetrasodium ethylene-diaminetetracetic acid	$\text{Na}_4\text{EDTA} \cdot 2\text{H}_2\text{O}$	5.5
chromium nitrate	$\text{Cr}(\text{NO}_3)_3 \cdot 9\text{H}_2\text{O}$	3.2
sodium phosphate	$\text{Na}_3\text{PO}_4 \cdot 12\text{H}_2\text{O}$	2.6
sodium chloride	NaCl	1.3
potassium nitrate	KNO_3	0.9
sodium sulfate	Na_2SO_4	0.6
ferric nitrate	$\text{Fe}(\text{NO}_3)_3 \cdot 9\text{H}_2\text{O}$	0.2
calcium nitrate	$\text{Ca}(\text{NO}_3)_2 \cdot 4\text{H}_2\text{O}$	0.1
nickel nitrate	$\text{Ni}(\text{NO}_3)_2 \cdot 6\text{H}_2\text{O}$	0.1
sodium fluoride	NaF	0.1
zinc chloride	ZnCl_2	Trace
cesium nitrate	CsNO_3	Trace
strontium nitrate	$\text{Sr}(\text{NO}_3)_2$	Trace
free water	H_2O (free)	27.5

Table A.4. T-Plant "Top" Simulant Composition.

ammonium hexafluorosilicate	$(\text{NH}_4)_2\text{SiF}_6$	9.4
sodium nitrate	NaNO_3	7.2
sodium phosphate	Na_3PO_4	6.6
ferric hydroxide	$\text{Fe}(\text{OH})_3(\text{Fe}_2\text{O}_3)$	4.9
disodium nickel ferrocyanide	$\text{Na}_2\text{NiFe}(\text{CN})_6$	2.6
sodium nitrite	NaNO_2	2.2
chromium nitrate	$\text{Cr}(\text{NO}_3)_3$	1.5
sodium sulfate	Na_2SO_4	0.6
bismuth phosphate	BiPO_4	0.5
zirconium phosphate	$\text{Zr}_3(\text{PO}_4)_4$	0.1
cesium nitrate	CsNO_3	Trace
water (bound)	H_2O	1.2
water (free)	H_2O	69.0

Table A.5. T-Plant "Bottom" Simulant Composition.

bismuth phosphate	BiPO_4	31.2
ammonium hexafluorosilicate	$(\text{NH}_4)_2\text{SiF}_6$	5.2
sodium nitrate	NaNO_3	2.5
ferric hydroxide	$\text{Fe}(\text{OH})_3$	2.1
disodium nickel ferrocyanide	$\text{Na}_2\text{NiFe}(\text{CN})_6$	0.8
sodium nitrite	NaNO_2	0.8
chromium nitrate	$\text{Cr}(\text{NO}_3)_3$	0.7
sodium sulfate	Na_2SO_4	0.3
zirconium phosphate	$\text{Zr}_3(\text{PO}_4)_4$	0.3
cesium nitrate	CsNO_3	Trace
water (bound)	H_2O	0.6
water (free)	H_2O	45

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APPENDIX B:
NEON CALIBRATION AND SODIUM-VAPOR LAMP SPECTRA

Figure B.1. Neon Calibration Lines for Kaiser 532-nm Spectrograph (167- μ m slit).

Figure B.2. Neon Calibration Lines for Kaiser 785-nm Spectrograph (167- μ m slit).

Figure B.3. Spectrum of High-Pressure Sodium Vapor Lamp: 800 - 920 nm.

Figure B.4. Spectrum of High-Pressure Sodium Vapor Lamp: 910 - 1040 nm.

APPENDIX C: RAMAN COMPARISON SPECTRA AT 532 NM AND 785 NM

Experimental Conditions

Table C.1 outlines the experimental conditions used to collect the data shown in Figures C.1 - C.9.

Table C.1. Experimental Conditions for Figures C.1 - C.9.

Laser	Adlas, Inc., DPY 425II doubled Nd-YAG	SDL, Inc., SDL-8630 tunable diode
Probe	WSRC LDUA 1:6 with 532-nm optical filter set	WSRC LDUA 1:6 with 785-nm optical filter set
Laser power at sample	22 mW	27 mW
Spectrometer	Kaiser Optical Systems, Inc., HoloSpec f/1.8i	Kaiser Optical Systems, Inc., HoloSpec f/1.8i NIR
Slit width	167 μm	167 μm
Gratings	HSG-532-LF (200-2400 cm^{-1}) HSG-532-HF (1750-4000 cm^{-1})	HSG-785-LF (450-1800 cm^{-1}) HSG-785-HF (1770-3100 cm^{-1})
Detector	Princeton Instruments, Inc., TEA/CCD-1152EM/1 at -40°C	Princeton Instruments, Inc., LN/CCD-1024TKB at -120°C
Total integration time*	300 sec	300 sec

*Total integration time for spectra of sodium nitrate, acetonitrile, and cyclohexane is 60 seconds.

Figure C.1. Sodium Nitrate Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.2. Acetonitrile Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.3. Cyclohexane Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.4. Sodium Nickel Ferrocyanide Raman Spectra Using 532-nm and 785-nm Excitation

Figure C.5. BY-104 Simulant Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.6. In-Farm 2 Simulant Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.7. SY-101 Simulant Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.8. T-Plant (Bottom Fraction) Simulant Raman Spectra Using 532-nm and 785-nm Excitation.

Figure C.9. T-Plant (Top Fraction) Simulant Raman Spectra Using 532-nm and 785-nm Excitation.

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